

INDIAN INSTITUTE OF TECHNOLOGY BOMBAY

MATERIALS MANAGEMENT DIVISION

Powai, Mumbai - 400076

Technical Specifications for Probe Card

Specifications to Match or exceed :

1.List of at least 5 international semiconductor industrial customers

2.Wire harness from probe card to C20 (AMP Micro Coax Plug) socket;

3.Connector is C21 (Micro coaxial AMP Socket) from probe card side to C01 (Tri axial 3-Lug Plug)

4.Temperature of chip testing: -65°C to +300°C

Connector / Cable performance

5.Series Resistance @25°C: less than 1 Ohms per Meter

6.Conductor-to-Conductor Leakage @ 25°C: less than 1 fA/V @ 1 Sec

7.Center-to-Guard Isolation @ 25°C: > 10 T Ohm @ 1 Sec

8.Maximum Voltage Per Cable: 600V

9.Max Current Per Cable: 1.7A

- 10.Ambient Temperature Range: -27° to +105°C
- 11. Provide drawings of adapters to attach to Suss PM6 and Suss PM8 probe stations

Form Factor

12.Length: 152 mm +/- 10mm

13.Width: 114 mm +/- 10mm

Probe card specs

- 14.Nominal Overdrive: 25 to 75um (1 to 3 mils)
- 15.Temperature Range: -65°C to +300°C
- 16.Highest Voltage Per Channel: 200V
- 17. Highest Current Per Channel: 250mA

20 pin Probe card

- 18. Probe Pad Materials and thickness: Al
- 19.Pad Size(mm): 0.075 x 0.075mm
- 20.X axis Spacing: 0.125mm X axis: 10 columns
- 21.Y Axis Spacing: 0.1550 Y Axis: 2 rows
- 22.*MTP: 4.7mm (185 mils) *MTP = bottom of Mounting surface To Probe tip measurement"
- 23. The probe card must be ceramic-based to enable temperature range of operation Confirmed
- 24.Probe Type: 10milØ WRe
- 25.Probe Tip R: 18±4µm
- 26.Probe Count: 20
- 27.Connector Type: C20- AMP Co axicon Plug
- 28.Connector Count: 20 + GND
- 29.Integrated cable harness: Coaxial
- 30.Cable Harness Length: 35cm
- 31.Harness cable Count: 20 + GND
- 32.Back shell Type: C20 (AMP Plug)
- 33.Back shell Count: 1

32 pin Probe card

- 34.Probe Pad Materials and thickness: Al
- 35.Pad Size(mm): 0.075 x 0.075mm
- 36.X axis spacing: 0.1200mm X axis: 16 columns
- 37.Y Axis spacing: 0.1700 Y Axis: 2 rows
- 38.*MTP: 4.7mm (185mils) *MTP = bottom of Mounting surface To Probe tip measurement"
- 39. The probe card must be ceramic based to enable temperature range of operation
- 40.Probe Type: 10milØ WRe
- 41.Probe Tip R: 18±4µm
- 42.Probe Count: 32
- 43.Connector Type: C20- AMP Co axicon Plug
- 44.Connector Count: 32 + 2 GND
- 45.Pigtail Type: Coaxial
- 46.Cable Harness Length: 35cm
- 47.Harness cable Count: 32 + 2 GND
- 48.Back shell Type: C20 (AMP Plug)
- 49.Back shell Count: 2

Connector 1: Essentially this should be sufficient for 20-pin probe card. It should also be sufficient for 32-pin probe card along with connector 2.

- 50.Switch Matrix-Side Connector: C01 (Tri axial 3-Lug Plug)
- 51.Connector Count: 25
- 52.Cable Type: W01 (Ultra Low-Leakage Tri axial)
- 53.Cable Length: 300.0cm (3.0Meters)
- 54.Cable Count: 25
- 55.Probe card-Side Connector: C21 (Micro coaxial AMP Socket)

56.Connector Count: 25 + Ground Pin (Channel 26)

57.Back shell Type: C21 (AMP Socket)

58.Backs hell Count: 1

Connector 2: should work with 32-pin probe card (along with connector 1)

59.Switch Matrix-Side Connector: C01 (Tri axial 3-Lug Plug)

60.Connector Count: 11

61.Cable Type: W01 (Ultra Low-Leakage Tri axial)

62.Cable Length: 3.0 Meters

63.Cable Count: 11

64. Probe card-Side Connector: C21 (Micro-coaxial AMP Socket)

65.Connector Count: 11 + GND

66.Backs hell Type: C21 (AMP Socket)

67.Back shell Count: 1

Connector / Cable performance

68.Series Resistance @ 25°C: less than 10hms per meter

69.Conductor-to-Conductor Leakage @ 25°C: less than 1fA/V @ 1 sec

70.Center-to-Guard Isolation @ 25°C: > 10 T Ohm @ 1 Sec

71.Maximum Voltage Per Cable: 600V

72.Max Current Per Cable: 1.7A

73.Ambient Temperature Range: -27° to +105°C